Component Parameter Test Instruments

I. TH510 Series Semiconductor C-V Characteristic Analyzer

Features

■ integrated design:

LCR+gate voltage $V_{\rm DS}$ +drain voltage $V_{\rm DS}$ +channel switching+host computer software

- Gate voltage V_{GS}: 0 ±40V
- Drain voltage V_{DS}: 0 ±200V/±1500V/±3000V
- Single tube device (spot test), module device (list scan), curve scan (optional)
 Three testing methods
- Four parasitic parameters (Ciss,Coss,Crss,Rg or Cies,Coes,Cres,Rg)
 One-click measurement and display on the same screen
- Standard 2 channels, expandable to 6 channels, capable of testing single tube, multi-core or module devices (TH511E/TH513 only has 1 channel)
- CV curve scan, Ciss-Rg curve scan
- Capacitor fast charging technology enables fast testing
- Contact Check Cont
- Continuity test OP_SH
- Automatic delay setting
- Crss Plus function: solve the problem of negative Crss value at high frequency
- High-voltage breakdown protection: Solve the problem of excessive gate voltage recoil instrumentation
- Interlock safety lock function: add high-voltage protective wall (TH513 only)
- Cs-V function: test and analysis of diode junction capacitance CV characteristics
- Equivalent mode conversion function, optional Cs or Cp mode
- 10 levels of sorting

TECHNIZE TH511 Semocrobulor CV Analyzes TO 1.10532 0 TO 1.36330 nF TO 1.36330

RS232	LAN	HANDER	USB HOST	USB DEVICE	RS485
standard	standard	standard	standard	standard	option

TH510 Series

Dimension: 430(W)x177(H)x265(D)

Weight : about 16kg

Applications

■ Semiconductor components/Power components

Parasitic capacitance test and C-V characteristic analysis of diodes, triodes, MOSFETs, IGBTs, thyristors, integrated circuits, optoelectronic chips, etc.

■ Semiconductor material

Wafer dicing, C-V characteristic analysis

Liquid crystal material

Elastic constant analysis

Specifications

Model		TH511E	TH511	TH512	TH513		
Channel		1	2 (2/4 Ch Optional)		1		
Display	Display	10.1-inch capacitive	10.1-inch capacitive touchscreen				
	Ratio	16:9	16:9				
	Resolution	1280×RGB×800	1280×RGB×800				
Test Parameter		C_{ISS} , C_{OSS} , C_{RSS} , R_g .	$C_{ISS},C_{OSS},C_{RSS},R_g$. Four parameter selectable arbitrarily				
LCR mode		\checkmark					
Test Frequency	Range	10kHz-500kHz	10kHz-2MHz				
	Accuracy	0.01%	0.01%				
		10mHz	1.00	1.00000kHz-9.99999kHz			
	Resolution	100mHz	10.0	10.0000kHz-99.9999kHz			
		1Hz	100.	100.000kHz-999.999kHz			
		10Hz	1.00	1.00000MHz-2.00000MHz			
Test Level	Voltage Range	5mVrms-2Vrms	5mVrms-2Vrms				
	Accuracy	± (10% x Setting Va	± (10% x Setting Value+2mV)				
	Resolution	1mVrms	5mV	5mVrms-1Vrms			
		10mVrms	1Vrn	1Vrms-2Vrms			
V_{GS}	Range	0 - ±40V	0 - ±40V				
	Accuracy	1% x Setting Voltag	1% x Setting Voltage+8mV				
	Resolution	1mV	0V -	0V - ±10V			
		10mV	0mV ±10		±10V - ±40V		
V _{DS}	Range	0 - ±200V		0 - ±1500V	0 - ±3000V		
	Accuracy	1%×Setting Voltage	×Setting Voltage + 100mV				

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Output Impedance			100Ω, ±2%@1kHz			
Computation			Absolute deviation Δ from nominal value, percent deviation from nominal value $\Delta\%$			
Calibration Function			OPEN, SHORT, LOAD			
Measure Average			1-255 times			
AD Conversion Time (ms/time)		÷)	Fast+: 2.5ms (> 5kHz), Fast: 11ms, Middle: 90ms, Slow: 220ms.			
Basic Accuracy			0.1%			
C _{ISS} , C _{OSS} , C _{RS}	SS		0.00001pF - 9.99999F			
Rg			0.001mΩ - 99.9999MΩ			
Δ%			± (0.000% - 999.9%)			
	Spots		20 spots, the average number can be set for each spot, and each spot can be sorted separately			
Multi-Function	Parameter		Test Frequency, Vg, Vd, Channel			
Parameter List Scan	Trigger Mode		Sequence SEQ: After one trigger, measure at all sweep points, /EOM/INDEX output only once.			
			Step: perform a sweep point measurement per trigger, each point outputs /EOM/INDEX, but the list scan comparator result is only output at the last /EOM			
	Scanning Sp	oots	Any Spot is optional, up to 1001 Spots			
	Result Display		Multiple curves with the same parameter and different Vg; multiple curves with the same Vg and different parameters.			
	Display Range		Real-time automatic, locked			
Graphic Scan	Coordinate r	uler	Logarithmic, linear			
Graphic Scari	Parameter		Vg、Vd			
	Trigger Mode	Single	Manual trigger once, complete one scan from the start spot to the end spot, and start a new scan with the next trigger signal			
		Continuous	Infinite loop scan from the start spot to the end spot			
	Result Storage		Graphics, files			
	Bin		10Bin、PASS、FAIL			
	Bin Deviation Setting		Deviation, Percent Deviation, Off			
	Bin Mode		Tolerance, continuous			
Comparators	Bin Count		0-99999			
Comparators	Bin Judgement		A maximum of four parameter limit ranges can be set for each bin. The corresponding bin number will be displayed within the setting range of the four test parameter results. If it exceeds the set maximum bin number range, FAIL will be displayed. Test parameters without upper and lower limits will be automatically ignored.			
	PASS/FAIL indication		Satisfy Bin1-10, the PASS light on the front panel is on, otherwise the FAIL light is on.			
Data Storage			201 measurement results can be read in batches			
Storago Eilo	Internal		About 100M non-volatile memory test setup file			
Storage File	External USB		Test setup files, screenshots, log files			
Keyboard Lock			Lockable front panel buttons, other functions to be expanded			
Interface	USB HOST		2 USB HOST interfaces, which can be connected to the mouse and keyboard at the same time, and only one U disk can be used at the same time			
	USB DEVICE		Universal Serial Bus socket, small type B (4 contact positions); compliant with USB TMC-USB488 and USB2.0, female connector for connecting external controllers.			
	LAN		10/100M Ethernet, 8 pins, two speed options			
	HANDLER		Used for Bin signal output			
	RS232C		Standard 9-pin, crossed			
RS485			Can receive modification or external RS232 to RS485 module			
Boot Warm-up Time			60 Minutes			
Power consumption			100-120VAC/198-242VAC Option, 47-63Hz			
Power consumption			More than 130VA			
Dimensions (W	VxHxD) mm		430x177x405			
Weight			16kg			